

## SWCX1 SWEPT QUARTZ CRYSTAL

6 MHz to 250 MHz

Radiation Resistant, Surface Mount

# DESCRIPTION

For applications that require resistance to radiation, Statek offers swept quartz AT-cut resonators. Made with cultured quartz that is electrically "swept" at high temperature, these resonators are superior to those utilizing non-swept quartz in maintaining their frequency and other electrical characteristics under exposure to radiation levels of 100 krad (1 kGy) and greater. As Rad-Hard applications typically require various degrees of highreliability components, Statek offers these resonators in three distinct screening options to meet mission critical program requirements from Engineering to Flight.

## **FEATURES**

- Radiation tolerance up to 100 kRad total dose
- High shock resistance, three point mount\*
- Ultra high reliability
- Custom designs available
- Military and space screening available
- Low aging
- Critical processes performed in class 10 cleanroom
- Designed, manufactured and tested in the USA

#### **APPLICATIONS**

Military & Aerospace

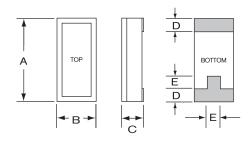
- Satellite
- Space exploration systems
- Deep space probes
- Telemetry

#### PACKAGING OPTIONS

- Tray Pack
- 16mm tape, 7" or 13" reels Per EIA 481 (see Tape and Reel datasheet 10109)

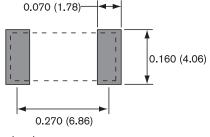


## PACKAGE DIMENSIONS



DIM	Termination	TYP	ICAL	MAXIMUM		
		inches	mm	inches	mm	
Α		0.315	8.00	0.330	8.38	
В		0.140	3.56	0.155	3.94	
С	SM1	_	_	0.070	1.78	
С	SM3	_	_	0.075	1.90	
D		0.045	1.14	0.055	1.40	
Е		0.060	1.52	0.070	1.78	

#### SUGGESTED LAND PATTERN



inches (mm)

# TERMINATIONS AVAILABLE SM

**Designation Termination** SM<sub>1</sub> Gold Plated SM3 Solder Dipped

10199 Rev E



<sup>\*</sup> Meets NASA EEE-INST-002

## ELECTRICAL SPECIFICATIONS TABLE<sup>1</sup> (Specifications shown are typical unless otherwise noted.)

SM	Frequency Range	Motional Resistance R1 @ 25°C	Motional Capacitance C1 @ 25°C	Shunt Capacitance C0 @ 25°C	Quality Factor (Q) @ 25℃	Load Capacitance CL	Drive Level
SWCX1 SWCX1	6.0 MHz to 250 MHz	_	0		30 k @ 32 MHz 30 k @ 155.2 MHz	1 1	500 μW Max f ≤ 50 MHz 200 μW Max f > 50 MHz

#### GENERAL SPECIFICATIONS TABLE<sup>1</sup> (Specifications shown are typical unless otherwise noted.)

SM	Frequency Range	Calibration Tolerance @ 25℃	Frequency Temperature Stability	Aging, first year	Shock, survival <sup>2</sup>	Vibration, survival	Standard CX data sheet
SWCX1 SWCX1	6.0 MHz to 250 MHz	±100 ppm, or tighter as required	Please refer to CX1 AT data sheet	2 ppm Max	3,000 g peak 0.3 ms, 1/2 sine		10127 CX1 AT/ 10107 CX1 SM AT

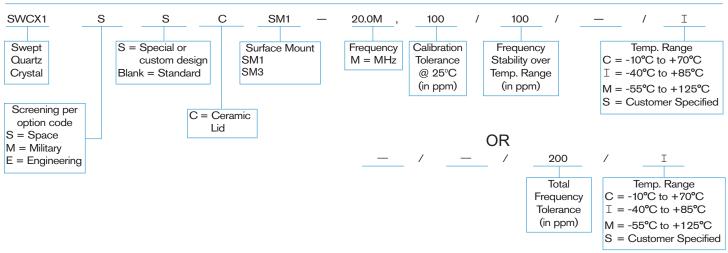
<sup>1.</sup> For more detailed specifications on crystals, refer to standard crystal datasheets.

#### **STANDARD TESTS & SCREENING OPTIONS**

Code			Item	Method	Comments		
S	M	E					
Х	Х	Х	Made with swept quartz				
Х	Х		Internal visual (pre-seal)	Statek internal standard			
Х			PIND testing	MIL-STD-883 Method 2020 Condition A	Performed in both the width and thickness directions.		
Х			Radiographic inspection	MIL-STD-202 Method 209			
Х	Х		Unwanted modes	MIL-PRF-3098	Spurious-mode ratio 2:1 or greater		
Х	х		Low temperature storage	MIL-PRF-3098	Resistance must meet specifications at this low temperature.		
Х	х		Frequency and resistance over operating temperature range	MIL-PRF-3098	Measure every 2.5°C or tighter over operating temperature range; frequency and resistance must meet specification.		
Х	х		Accelerated aging	105°C for 160 hours	Frequency and resistance must meet specification after aging; maximum allowed change in series frequency 5 ppm.		
Х	х	Х	Seal test (fine leak)	MIL-STD-883 Method 1014 Condition A1			
Х	Х	Х	Seal test (gross leak)	MIL-STD-883 Method 1014 Condition C			
Х	Х	Х	Final electrical test	π-network measurement per IEC 60444	Measure F <sub>S</sub> , R <sub>1</sub> , C <sub>1</sub> , C <sub>0</sub> , Q and F <sub>L</sub>		
Х	х	Х	External visual (post seal)	Statek internal standard			

S: For space-based applications.

## HOW TO ORDER SWCX1 SWEPT CRYSTALS NOTE: Example only. For specific ordering requirements, call us at ++1 714-639-7810



10199 Rev E



<sup>2.</sup> Higher shock available.

M: For military applications.

E: For engineering prototypes and applications not requiring the additional screening.